

EMC TEST REPORT

For

China Etech Groups Ltd Car charger

Model No. : ECC014

Prepared By: Shenzhen Certification Technology Service Co., Ltd.

: 2F, Building B, East Area of Nanchang Second Industrial Zone, Gushu 2nd Road, Bao'an District, Shenzhen 518126, P.R. China Address

Tel: 400-6786199 Fax: (0755) 26736857

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TEST REPORT VERIFICATION

Applicant

Manufacturer

EUT Description : Car charger

(A) Model No. : ECC014

(B) Trademark : N/A

(C) Ratings Supply: DC 12V

(D) Test Voltage : DC 12V From Battery

Measurement Standard Used:

EN 55022:2010 (Class B)

EN 55024:2010

(IEC 61000-4-2:2008; IEC 61000-4-3:2006+A1:2007+A2:2010)

The device described above is tested by Shenzhen Certification Technology Service Co., Ltd. to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The test results are contained in this test report and Shenzhen Certification Technology Service Co., Ltd. is assumed full responsibility for the accuracy and completeness of test. Also, this report shows that the EUT is technically compliant with the EN 55022, EN 61000-3-2, EN 61000-3-3 and EN 55024 requirements.

This report applies to above tested sample only.

Tested by (name + signature)......

Test Engineer

Approved by (name + signature)...: Simple Guan

Project Manager

Date of issue December 19, 2014

1. SUMMARY OF STANDARDS AND RESULTS

1.1. Description of Standards and Results

	EMISSION			
Description of Test Item	Standard	Lin	nits	Results
Conducted disturbance at mains terminals	EN 55022: 2010	Clas	ss B	N/A
Conducted disturbance at elecommunication port EN 55022: 2010 Class B		N/A		
Radiated disturbance	EN 55022: 2010	Clas	Class B	
Harmonic current emissions	EN61000-3-2:2006+ A1:2009+A2:2009		N/A	
Voltage fluctuations & flicker	EN 61000-3-3:2013	Secti	Section 5	
	IMMUNITY (EN 55024	: 2010)	·	
Description of Test Item	Basic Standard	Performance Criteria	Observation Criteria	Results
Electrostatic discharge (ESD)	IEC 61000-4-2:2008	В	В	PASS
Radio-frequency,	IEC 61000-4-3:2006+	The Technology	1111	PASS

Basic Standard	Criteria	Observation Criteria	Results
IEC 61000-4-2:2008	B	В	PASS
IEC 61000-4-3:2006+ A1:2007+A2:2010	A	A	PASS
IEC 61000-4-4:2012	В	N/A	N/A
IEC (1000 4 5-2005	В 111/	N/A	N/A
1EC 61000-4-3:2003	В	N/A	N/A
IEC 61000-4-6:2008	A	N/A	N/A
IEC 61000-4-8:2009	A	N/A	N/A
Juliu 11/1	В	N/A	N/A
IEC 61000-4-11:2004	C	N/A	N/A
	C	N/A	N/A
	IEC 61000-4-2:2008 IEC 61000-4-3:2006+ A1:2007+A2:2010 IEC 61000-4-4:2012 IEC 61000-4-5:2005 IEC 61000-4-6:2008 IEC 61000-4-8:2009	IEC 61000-4-2:2008 B IEC 61000-4-3:2006+	IEC 61000-4-2:2008 B B IEC 61000-4-3:2006+

N/A is an abbreviation for Not Applicable.

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2. GENERAL INFORMATION

2.1. Description of Device (EUT)

Description : Car charger

Classification Class III

Model Number : ECC014

EUT : Input: DC 12V

Output: DC 5V, 1000mA

Trademark : N/A

Applicant : China Etech Groups Ltd

Address : Room 3A15, Floor 4, Block C, Bao Yuan Huafeng Headquarter,

economy building, Xixiang Road, Xixiang street, Bao an District,

Shenzhen, China

Manufacturer : China Etech Groups Ltd

Address : Room 3A15, Floor 4, Block C, Bao Yuan Huafeng Headquarter,

economy building, Xixiang Road, Xixiang street, Bao an District,

Shenzhen, China

Sample Type : Prototype production

2.2. Tested Supporting System Details

No.	Description	Manufacturer	Model	Se	rial Number	
1.	Battery (12V)	N/A	N/A	Cerulicatio	N/A	3111
2.	Load	N/A	N/A	111/	N/A	Carilla don

	Signal Cable Description of the above Support Units						
No. Port Name		Cable	Cable Length		Detachable (Yes or No)		
1.	N/A	N/A	N/A	N/A	N/A		

2.3. Block Diagram of connection between EUT and simulators

For EMI Tests



For EMS Tests



EUT: Car charger

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2.4. Test Facility

2.4.1. Laboratory Name:

Shenzhen Certification Technology Service Co., Ltd.

2.4.2. Site Location:

2F, Building B, East Area of Nanchang Second Industrial Zone, Gushu 2nd Road, Bao'an District, Shenzhen 518126, P.R. China

2.4.3. Test facility:

JAN 13, 2012 File on Federal Communication Commission Registration Number: 197647

October 11, 2011 Certificated by IC Registration Number: 8528B

2.5. Measurement Uncertainty

(95% confidence levels, k=2)

Test Item	Uncertainty	$ m U_{cispr}$
Uncertainty for Conduction emission test	2.50dB	3.8 dB
	3.04 dB (Distance:	in the atlant
Uncertainty for Padiation Emission test	3m Polarize: V)	5.2 dB
Uncertainty for Radiation Emission test	3.02 dB (Distance:	3.2 UD
Edward 111/	3m Polarize: H)	31111
Zatados Zana	3.56 dB (Distance:	- Jon Technol
Uncertainty for Radiation Emission test	3m Polarize: V)	5.2 dB
(1GHz-18GHz)	3.84 dB (Distance:	3.2 UD
ation feature 11111/	3m Polarize: H)	111/1/1/1/1/1/1/1/1/1/1/1/1/1/1/1/1/1/1/
Uncertainty for Flicker test	0.05%	N/A
Uncertainty for Harmonic test	1.8%	N/A



2.6. Test mode Description

×1. Full Load	Amatoles
2. Half Load	E
3. No Load	

Note: * is worst case mode, so this report only reflected the worst mode

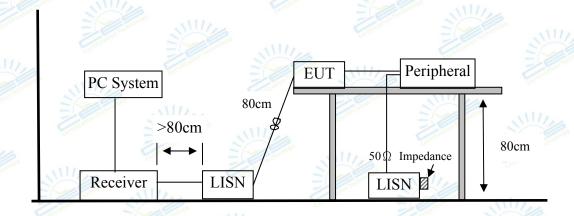


3. CONDUCTED DISTURBANCE AT MAINS TERMINALS TEST

3.1. Test Equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1. certific	Test Receiver	Rohde & Schwarz	ESCI	100843	Jan 20, 14	1 Year
2.17	L.I.S.N.#1	Schwarzbeck	NSLK8126	8126466	Jan 20, 14	1 Year
3.	L.I.S.N.#2	Kyoritsu	KNW-242C	8-1920-1	Jan 20, 14	1 Year
4.	Terminator	Hubersuhner	50Ω	No. 1	Jan 20, 14	1 Year
5.	RF Cable	Schwarzbeck	9111505/200	5995-12-161- 6890#	Jan 20, 14	1 Year
6.	Coaxial Switch	Schwarzbeck	CX-210	N/A	Jan 20, 14	1 Year
7.	Pulse Limiter	Schwarzbeck	VTSD9516F	9618	Jan 20, 14	1 Year

3.2. Block Diagram of Test Setup



3.3. Test Standard

EN 55022: 2010, Class B

3.4. Power Line Conducted Disturbance at Mains Terminals Limit

	Maximum R	F Line Voltage	
Frequency	Quasi-Peak Level	Average Level	
	dB(µV)	dB(µV)	
150kHz ~ 500kHz	66 ~ 56*	56 ~ 46*	
500kHz ~ 5MHz	56	46	
5MHz ~ 30MHz	60	50	

Notes: 1. Emission level=Read level+LISN factor-Preamp factor+Cable loss

- 2 * Decreasing linearly with logarithm of frequency.
- 3. The lower limit shall apply at the transition frequencies.

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3.5. EUT Configuration on Test

The following equipments are installed on Conducted Emission Test to meet EN 55022 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

3.5.1. Support Equipment: As Tested Supporting System Detail, in Section 2.2.

3.6. Operating Condition of EUT

- 3.6.1. Setup the EUT and simulator as shown as Section 3.2.
- 3.6.2. Turn on the power of all equipment.
- 3.6.3. Let Car charger (EUT) work in test mode (Full Load) and measure it.

3.7. Test Procedure

The EUT was placed on a non-metallic table, 80cm above the ground plane. The EUT Power connected to the power mains through a line impedance stabilization network (L.I.S.N. 1#). This provided a 50-ohm coupling impedance for the EUT (Please refer to the block diagram of the test setup and photographs). The other peripheral devices power cord connected to the power mains through a line impedance stabilization network (L.I.S.N.#2). Both sides of power line were checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipments and all of the interface cables were changed according to EN 55022 Class B on conducted Disturbance test.

The bandwidth of test receiver (R & S ESHS20) is set at 10kHz.

The frequency range from 150kHz to 30MHz is checked. The test results are reported and test results for Conducted Disturbance Test on Section 3.8.

3.8. Conducted Disturbance at Mains Terminals Test Results

EUT power supplies by DC Power, so this item test not applicable.

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4. RADIATED DISTURBANCE TEST

4.1. Test Equipments

4.1.1. For frequency range 30MHz~1000MHz (At Semi Anechoic Chamber)

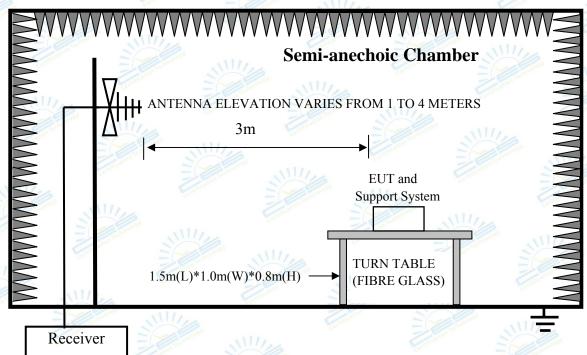
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1	Test Receiver	Rohde&Schwarz	ESCI	101165	Jan 20, 14	1 Year
2	Amplifier	Schwarzbeck	BBV9743	9743-019	Jan 20, 14	1 Year
3	Bilog Antenna	Schwarzbeck	VULB 9168	9168-438	Jan 22, 14	2 Year
4	RF Cable	Schwarzbeck	AK9515E	95891-2m	Jan 20, 14	1 Year
5	RF Cable	Schwarzbeck	AK9515E	95891-11m	Jan 20, 14	1 Year
6	RF Cable	Schwarzbeck	AK9515E	95891-0.5m	Jan 20, 14	1 Year

4.1.2. For frequency range 1GHz~6GHz (At Semi Anechoic Chamber)

	1000						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval	
1	Spectrum Analyzer	Agilent	E4407B	MY49510055	Jan 20, 14	1 Year	
2	Horn Antenna	Schwarzbeck	BBHA 9120 D	BBHA 9120 D(1201)	Jan 22, 14	2 Year	
3	Amplifier	Quietek	AP-180C	CHM-0602012	Jan 20, 14	1 Year	
4	RF Cable	Resenberger	Cable 4	N/A	Jan 20, 14	1 Year	
5/11/	RF Cable	Resenberger	Cable 5	N/A	Jan 20, 14	1 Year	
6	RF Cable	Resenberger	Cable 6	N/A	Jan 20, 14	1 Year	

4.2. Block Diagram of Test Setup

4.2.1. In Semi Anechoic Chamber (3m) Test Setup Diagram for 30MHz~1000MHz

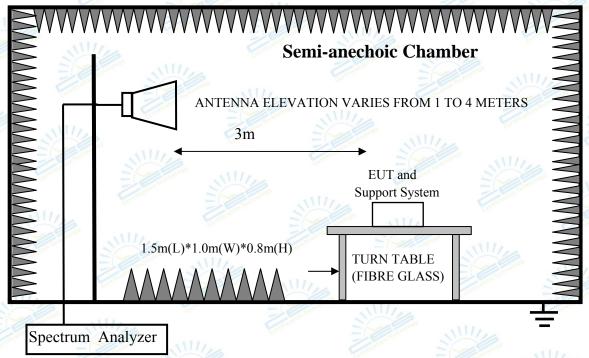


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4.2.2. In Semi Anechoic Chamber (3m) Test Setup Diagram for 1-6GHz



4.3. Test Standard

EN 55022: 2010, Class B

4.4. Radiated Disturbance Limit

All emanations from a Class B computing devices or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified below:

FREQUENCY (MHz)	DISTANCE (Meters)	FIELD STRENGTHS LIMITS (dBμV/m)
30 ~ 230	3 3 11//	40
230 ~ 1000	3	47
1000~3000	3	70(Peak) 50(Average)
3000~6000	3	74(Peak) 54(Average)

Note:

- (1) Emission level = Read level+Antenna Factor-Preamp Factor +Cable Loss
- (2) The lower limit shall apply at the transition frequencies.
- (3) Distance refers to the distance in meters between the test instrument antenna and the closed point of any part of the E.U.T.

4.5. EUT Configuration on Test

The EN 55022 Class B regulations test method must be used to find the maximum emission during Radiated Disturbance test. The configuration of EUT is same as used in Conducted Disturbance test. Please refer to Section 3.5.

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4.6. Operating Condition of EUT

- 4.6.1. Setup the EUT and simulator as shown as Section 4.2.
- 4.6.2. Turn on the power of all equipment.
- 4.6.3. Let Car charger (EUT) work in test mode (Full Load) and measure it.

4.7. Test Procedure

The EUT was placed on a non-metallic table, 80 cm above the ground plane inside a semi-anechoic chamber. An antenna was located 3m & 3m from the EUT on an adjustable mast. A pre-scan was first performed in order to find prominent radiated emissions. For final emissions measurements at each frequency of interest, the EUT were rotated and the antenna height was varied between 1m and 4m in order to maximize the emission. Measurements in both horizontal and vertical polarities were made and the data was recorded. In order to find the maximum emission, the relative positions of equipments and all the interface cables were changed according to EN 55022 Class B on Radiated Disturbance test.

The bandwidth setting on the test receiver (ROHDE&SCHWARZ TEST RECEIVER ESCI) is 120 kHz.

The resolution bandwidth of the Agilent Spectrum Analyzer E4407B was set at 1MHz. (For above 1GHz)

The frequency range from 30MHz to 1000MHz was pre-scanned with a peak detector and all final readings of measurement from Test Receiver are Quasi-Peak values.

The frequency range from 1GHz to 6GHz was checked with peak and average detector, measurement distance is 3m in 3m chamber.

Finally, selected operating situations at Semi Anechoic Chamber measurement, all the test results are listed in section 4.8.

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4.8. Radiated Disturbance Test Results

PASS. (All emissions not reported below are too low against the prescribed limits.)

The EUT with the following test mode was tested and read QP values, the test results are listed in next pages.

Temperature: 24.2°C Humidity: 54%

The details of test mode is as follows:

No.	Test Mode	
1.	Full Load	3111

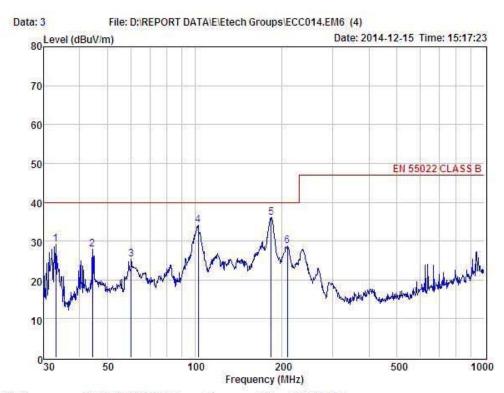
For frequency range 1GHz~6GHz

The highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz. So the frequency rang 1GHz-6GHz radiation test not applicable.

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POL: HORIZONTAL Condition : EN 55022 CLASS B 3m

EUT : Car charger : ECC014 Model No Test Mode : Full Load Power : DC 12V Test Engineer : Reak Remark

Temp : 24.2°C Hum : 54%

Read Cable Freq Antenna Preamp Level Limit Margin Remark Level Factor Factor Loss dBuV dBuV MHz dB dB dB dBuV dBuV 33.09 46.85 13.33 31.02 0.11 29.27 40.00 -10.73QP 27.86 2 45.23 13.79 QP 44.28 31.19 0.03 40.00 -12.1412.75 QP 3 60.28 43.55 31.31 0.24 25.23 40.00 -14.77QP QP 102.72 54.80 10.54 31.52 0.28 34.10 40.00 -5,90 183.84 55.38 11.20 0.56 36.00 40,00 -4.00 31.14 208.58 49.72 10.04 31.58 0.57 28.75 40.00 -11.25

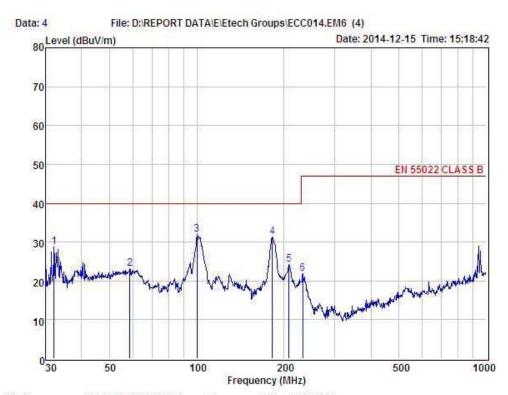
Remark: Level = Read Level + Antenna Factor - Preamp Factor + Cable Loss



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-1-





POL: VERTICAL Condition : EN 55022 CLASS B 3m

EUT : Car charger : ECC014 Model No Test Mode : Full Load Power : DC 12V Test Engineer : Reak Remark

Temp : 24.2°C Hum : 54%

207.85

232.53

5

45.38

41.02

Read Cable Freq Antenna Preamp Level Limit Margin Remark Level Factor Factor Loss dBuV dBuV MHz dB dB dB dBuV dBuV 32.07 46.42 13.28 30.98 0.11 28.83 40.00 -11.17 QP 2 12.75 QP 58.61 41.51 31.30 0.23 23.19 40.00 -16.81 52.75 QP 100.23 10.35 31.54 0.46 32.02 40.00 -7.98 182.56 50.37 11.44 31.12 0.56 31.25 40.00 -8.75 QP

0.49

0.56

24.33

21.82

Remark: Level = Read Level + Antenna Factor - Preamp Factor + Cable Loss

31.58

31.02

10.04

11.26

-2-



40.00

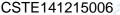
47.00

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QP

-15.67

-25.18

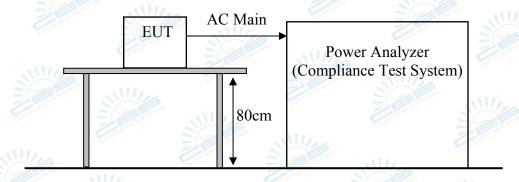


5. HARMONIC CURRENT TEST

5.1. Test Equipments

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Harmonics Flicker	Voltech	PM6000	200006700	Jan 20, 14	1 Year
	Analyser	indios th	Cor	495	Tallon Technic	

5.2. Block Diagram of Test Setup



5.3. Test Standard

EN 61000-3-2: 2006+A1:2009+A2:2009; Class A

5.4. Limits of Harmonic Current

2004		
	Limits for Class D Equipment	
Harmonic order (n)	Maximum permissible harmonic current per watt (mA/W)	Maximum permissible harmonic current (A)
3	3.4	0.23
5	1.9	1.14
7	1.0	0.77
9	0.5	0.40
11	0.35	0.33
13 Contraction	0.30	0.21
15≤n≤39 (odd harmonic only)	3.85/n	0.15×15/n



L	imits for Class A e	equipment	
Harmonic orde	er	Maximum permiss Harmonic curre	
n		A	
	Odd harmon	ics	1111
3	1/1/2	2,30	cimalo gu
5	recommodula 111/	1,14	
7	200	0,77	atton
9	incation	0,40	Cartiffic
11,17	Ceru	0,33	
13	94	0,21	1111/
15≤n≤39	31111	0.15 15	- Lectrosia
u Cortilea	- Judinoto	0.13 n	Hilleation
111/1/20	Even harmon		
12/		1,08	.117.
4	VII/2	0,43	1
6	S Colore	0,30	Ton Technology
8≤n≤40	Service attant technic	$0,23 \frac{8}{n}$	Certifica

Limits for Class C equipment							
Harmonic order	Maximum permissible harmonic current						
	expressed as a percentage of the input current						
	at the fundamental frequency						
n	%						
2	2						
3	30 · λ *						
5	111//_ 10						
7	- The Table 1						
9	5						
11≤n≤39	3						
(odd harmonics only)							
* λ is the circuit power factor							

5.5. Operating Condition of EUT

Same as Section 3.6. except the test setup replaced by Section 5.2.

5.6. Test Procedure

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the necessary for the EUT to be exercised.

5.7. Test Results

EUT power supplies by DC Power, so this item test not applicable.

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6. VOLTAGE FLUCTUATIONS & FLICKER TEST

6.1. Test Equipment

Same as Section 5.1.

6.2. Block Diagram of Test Setup

Same as Section 5.2.

6.3. Test Standard

EN 61000-3-3:2013

6.4. Limits of Voltage Fluctuation and Flick

Test Item	Limit	Note		
P _{st}	1.0	P _{st} means Short-term flicker indicator		
P _{lt} 0.65		P _{lt} means long-term flicker indicator		
T_{dt}	0.2	T_{dt} means maximum time that dt exceeds 3%		
d _{max} (%) 4% d _c (%) 3%		d _{max} means maximum relative voltage change.		
		d _c means relative steady-state voltage change.		

6.5. Operating Condition of EUT

Same as Section 5.5.

6.6. Test Procedure

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal conditions during the flick measurement, the measure time shall include that part of whole operation changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

6.7. Test Results

EUT power supplies by DC Power, so this item test not applicable.

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7. IMMUNITY PERFORMANCE CRITERIA

Performance Level

The test results shall be classified in terms of the loss of function or degradation of performance of the equipment under test, relative to a performance level by its manufacturer or the requestor of the test, or the agreed between the manufacturer and the purchaser of the product.

Definition related to the performance level:

- 1. Based on the used product standard
- 2. Based on the declaration of the manufacturer, requestor or purchaser

Performance criterion A

When seen from the normal viewing distance, the EUT shall operate with no change beyond the manufacturer's specification, in flicker, colour, focus and jitter (except for the power frequency magnetic field test).

Power frequency magnetic field test

For CRT monitors, the following also applies:

The jitter shall be measured using a measuring microscope as specified in 6.6.14 of ISO 9241-3.

The jitter (in mm) shall not exceed the value $\frac{\text{(character height in mm} + 0,3) \times 2,5}{33.3}$ when the CRT

monitor is immersed in a continuous magnetic field of 1A/m (r.m.s.) at one of the power frequencies of 50Hz.

Alternatively, a field of 50A/m may be applied, and a transparent graduated mask used to assess the jitter. In that case, the jitter shall not exceed 50 times the value in the above formula.

NOTE-This test level is used to simplify the measurement of jitter. Lesser values of the test level may be used if non-linearity is experienced, due to, for example, saturation of screening material.

The EUT shall be tested in two positions, both perpendicular to the magnetic field.

Performance criterion B

Screen disturbances during the application of the test are permissible.

Performance criterion C

Failures which are not self-recovered after removal of the external disturbance, but which can be recovered to normal operation by reset or reboot are permissible.

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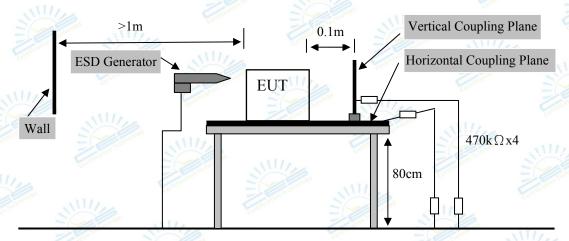
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8. ELECTROSTATIC DISCHARGE IMMUNITY TEST

8.1. Test Equipments

	Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1	1.	ESD Tester	HAEFELY	PESD1610	H310546	Jan 22, 14	1 Year

8.2. Block Diagram of Test Setup



8.3. Test Standard

EN 55024: 2010(IEC 61000-4-2: 2008) (Severity Level 1 & 2 & 3 for Air Discharge at 2 kV & 4 kV & 8kV, Severity Level 1 & 2 for Contact Discharge at 2 kV & 4kV)

8.4. Severity Levels and Performance Criterion

8.4.1. Severity level

Level	Test Voltage	Test Voltage
	Contact Discharge (kV)	Air Discharge (kV)
Ce Ticano	2	2
2.	4 Teamhort	4
1113.	6	8
4.	8	ettle aton
X	Special	Special

8.4.2. Performance criterion: B

8.5. EUT Configuration

The configurations of EUT are listed in Section 3.5.

8.6. Operating Condition of EUT

Same as Conducted Emission test that is listed in Section 3.6. except the test set up replaced by Section 8.2.



8.7. Test Procedure

8.7.1. Air Discharge:

The test was applied on non-conductive surfaces of EUT. The round discharge tip of the discharge electrode was approached as fast as possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a new single discharge and repeated 20 times for each pre-selected test point. This procedure was repeated until all the air discharge completed

8.7.2. Contact Discharge:

All the procedure was same as Section 8.7.1. except that the generator was re-triggered for a new single discharge and repeated 50 times for each pre-selected test point. The tip of the discharge electrode was touching the EUT before the discharge switch was operated.

8.7.3. Indirect discharge for horizontal coupling plane:

At least 20 single discharges were applied to the horizontal coupling plane, at points on each side of the EUT. The discharge electrode positions vertically at a distance of 0.1m from the EUT and with the discharge electrode touching the coupling plane.

8.7.4. Indirect discharge for vertical coupling plane:

At least 20 single discharges were applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, was placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges were applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

8.8. Test Results

PASS.

The EUT was tested and all the test results are listed in next page.

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Electrostatic Discharge Test Results

			9		
Applicant	:	China Etech Groups Ltd	Test Date	:	December 17, 2014
EUT	. av	Car charger	Temperature	:	24℃
M/N	:	ECC014	Humidity		56%
Test Voltage	:	DC 12V From Battery	Test Mode	7	Full Load
Test Engineer	:	Reak	Pressure	, C.	101.3KPa
Required Performance	:	Billy	Actual Performance	11/	В

Air Discharge: ±2kV ±4kV ±8kV # For Air Discharge each Point Positive 25 times and negative 25

times discharge.

Contact Discharge: ±2kV ±4kV # For Contact Discharge each point positive 25 times and negative 25

times discharge

For the time interval between successive single discharges an initial value of one second.

Discharg	e Type of	Dischargeable Points	Peri	formance	Result
Voltage (k		Dischargeable Points	Required	Observation	(Pass/Fail)
±2	Contact	1,3	B\1//	В	Pass
±4	Contact	1,3	В	B	Pass
±2	Air	2	В	В	Pass
±4	Air	2	В	В	Pass
±8	Air	2	В	В	Pass
±2	HCP-Bottor	n Edge of the HCP	В	AIII/A	Pass
±2	VCP-Front	Center of the VCP	В	A	Pass
<u>±2</u> ,	VCP-Left	Center of the VCP	В	A 📑	Pass
±2	VCP-Back	Center of the VCP	В	A	Pass
±2	VCP-Right	Center of the VCP	В	A	Pass
±4	HCP-Bottor	Edge of the HCP	В	A	Pass
±4	VCP-Front	Center of the VCP	В	A	Pass 1//
±4	VCP-Left	Center of the VCP	B	A	Pass
±4	VCP-Back	Center of the VCP	B	A	Pass
±4	VCP-Right	Center of the VCP	В	AIII	Pass
N177		Discharge Points Desc	ription 💮	= Jan red motor	1111/1
<u>1</u> Me	tal		<u>6</u>	Certifican	Technology.
<u>2</u> Slo	ts	Comment of the Commen	7	i i	Certification
<u>3</u> US	B port	Carelline Carelline	8	3111/16	
<u>4</u>	Zanaria.		9	E Common of the	1111/16
5	1.		10	Certificati	Technology

Test Equipment: ESD Tester (PESD1610)

Remark: 1. Class A is no function loss.

2. Class B is EUT slight change in voltage, but it can automatically reply.

Discharge was considered on Contact and Air and Horizontal Coupling Plane (HCP) and Vertical Coupling Plane (VCP).

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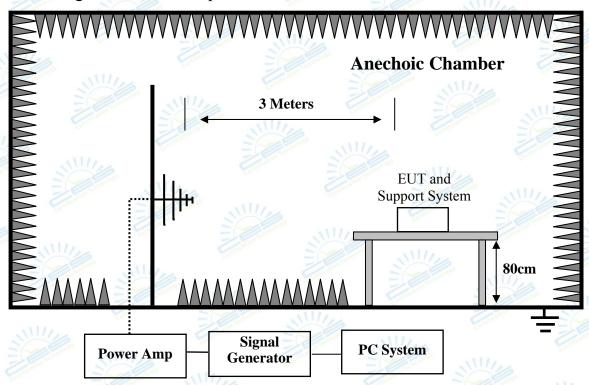


9. RF FIELD STRENGTH SUSCEPTIBILITY TEST

9.1. Test Equipments

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Signal Generator	Marconi	2031B	11606/058	Jan 20, 14	1 Year
2.	Amplifier	A&R	100W/1000M1	17028	NCR <	NCR
3.,	Isotropic Field Monitor	A&R	FM7004	0325983	NCR =	NCR
4.	Isotropic Field Probe	A&R	FL7006	0325736	Jan 20, 14	1 Year
5.	Laser Probe Interface	A&R	FL7000	325430	NCR	NCR 🥌
6.	Power Meter	Anritsu	ML2487A	6k00003262	Jan 20, 14	1Year
7.	Power Sensor	Anritsu	MA2491A	33005	Jan 20, 14	1Year
8.	Log-periodic Antenna	A&R	AT1080	16512	NCR	NCR

9.2. Block Diagram of Test Setup



9.3. Test Standard

EN 55024: 2010(IEC 61000-4-3:2006+A1: 2007+A2: 2010) (Severity Level: 2 at 3V / m)



9.4. Severity Levels and Performance Criterion

9.4.1. Severity level

Level	Test Field Strength V/m
Technology 1.	1 Internal
2.	311/1/3
3.	10
X	Special

9.4.2. Performance criterion: A

9.5. EUT Configuration

The configurations of EUT are listed in Section 3.5.

9.6. Operating Condition of EUT

Same as Conducted Emission test that is listed in Section 3.6. except the test set up replaced by Section 9.2.

9.7. Test Procedure

Testing was performed in a fully anechoic chamber as recommended by IEC 61000-4-3. The EUT was placed on an 80 cm high non-conductive table located in the area of field uniformity. The radiating antenna was placed 3m in front of the EUT and Support system, and dwell time of the radiated interference was controlled by an automated, computer-controlled system. The signal source was stepped through the applicable frequency range at a rate no faster than 1% of the fundamental. The signal was amplitude modulated 80% over the frequency range 80 MHz to 1GHz at a level of 3 V/m. The dwell time was set at 3 s. Field presence was monitored during testing via a field probe placed in close proximity to the EUT. Throughout testing, the EUT was closely monitored for signs of susceptibility. The test was performed with the antennae oriented in both a horizontal and vertical polarization.

All the scanning conditions are as follows:

All	Condition of Test	Remarks
1.	Test Fielded Strength	3 V/m (Severity Level 2)
2.	Radiated Signal	80% amplitude modulated with
		a 1kHz sine wave
3.	Scanning Frequency	80 - 1000 MHz
4.	Sweeping time of radiated	0.0015 decade/s
5.	Dwell Time	3 Sec.

9.8. Test Results

PASS.

The EUT was tested and all the test results are listed in next page.



RF Field Strength Susceptibility Test Results

Applicant	: China Etech Gr	roups Ltd	Test Dat	e : De	ecember 17, 2014
EUT	: Car charger	Continent	Tempera	iture: 24	${\mathbb C}$
M/N	: ECC014	111/16	Humidit	y : 56	%
Test Voltage	: DC 12V From	Battery	Test Mo	de : Fu	11 Load
Test Engineer	: Reak		Pressure	: 10	1.3KPa
Frequency Range	: 80 MHz -10001	MHz	Field Str	rength: 3V	7/m
Required Performance	: A	A LINE OF THE PARTY OF THE PART	Actual Performa	Till Co.	A STATE OF THE STA
Modulation:	☑ AM	☐ Pulse	none	1 kHz 80%	
	Treasure 11111	Eraguana	Dongo : 90 MHz	1000MHz	111/16
Steps	1%	Frequency	y Range :80 MHz	-1000MHz	
Steps		Frequency	1111/16	-1000MHz	Result
Steps		- Internation	1111/16	į	Cs
Steps	Hori	izontal	Ve	ertical	Co.
	Hori Required	izontal Observation	Ve Required	ertical Observa	tion (Pass / Fail)
Front	Required A	izontal Observation A	Ve Required A	ertical Observa	tion (Pass / Fail) Pass

Test Equipment:

Signal Generator : Marconi 2031B
 Power Amplifier : A&R 500A/100;100W/1000M.

3. Power Antenna: A&R AT-1080. 4. Field Monitor: A&R FM7004.

Remark: Class A is no function loss.

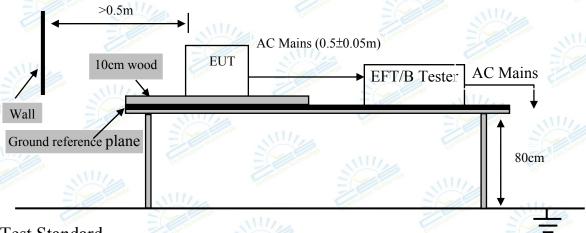


10. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

10.1. Test Equipments

i di	Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
	1.	Burst Tester	3ctest	EFT-4001G	EC0461015	Jan 20, 14	1 Year
		Meation	adost		3	atton Technic	

10.2. Block Diagram of Test Setup



10.3. Test Standard

EN 55024: 2010(IEC 61000-4-4:2012) (Severity Level 2 at 1kV)

10.4. Severity Levels and Performance Criterion

10.4.1. Severity level

	Open Circuit Output Test Voltage ±10%				
Level	On Power Supply	On I/O (Input/Output)			
	Lines	Signal data and control lines			
1.	0.5 kV	0.25 kV			
2.//	1 kV	0.5 kV			
3.	2 kV	1 kV			
4.	4 kV	2 kV			
X	Special	Special			

10.4.2. Performance criterion: **B**

10.5. EUT Configuration

The configurations of EUT are listed in Section 3.5.

10.6. Operating Condition of EUT

Same as Conducted Emission test that is listed in Section 3.6. except the test set up replaced by Section 10.2.



10.7. Test Procedure

The EUT and its simulators were placed on the ground reference plane and were insulated from it by a wood support $0.1m \pm 0.01m$ thick. The ground reference plane was 1m*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane was project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane was more than 0.5m. All cables to the EUT was placed on the wood support, cables not subject to EFT/B was routed as far as possible from the cable under test to minimize the coupling between the cables.

10.7.1. For input and AC power ports:

The EUT was connected to the power mains by using a coupling device that couples the EFT interference signal to AC power lines. Both positive transients and negative transients of test voltage were applied during compliance test and the duration of the test can't less than 1min.

10.7.2. For signal lines and control lines ports:

It's unnecessary to test.

10.7.3. For DC input and DC output power ports:

It's unnecessary to test.

10.8. Test Results

EUT power supplies by DC Power, so this item test not applicable.

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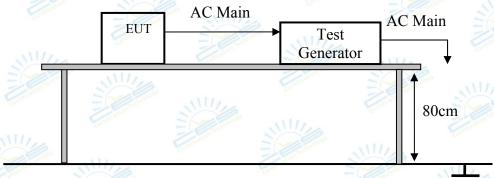


11. SURGE TEST

11.1. Test Equipments

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Surge CDN	3ctest	SGN-5010G	EC5591004	Jan 20, 14	1 Year
2.	Surge Generator	3ctest	SG-5006G	EC5581006	Jan 20, 14	1 Year

11.2. Block Diagram of Test Setup



11.3. Test Standard

EN 55024: 2010 (IEC 61000-4-5: 2005) (Severity Level: Line to Line was Level 2 at 1kV)

11.4. Severity Levels and Performance Criterion

11.4.1. Severity level

	Severity Level	Open-Circuit Test Voltage
1		kV
	Tradinguous 1	0.5
Co	2	1.0
	3	2.0
ı	1/1 4	4.0
	*	Special

11.4.2. Performance criterion: B

11.5. EUT Configuration

The configurations of EUT are listed in Section 3.5.

11.6. Operating Condition of EUT

Same as Conducted Emission test that is listed in Section 3.6. except the test set up replaced by Section 11.2



11.7. Test Procedure

- 1) Set up the EUT and test generator as shown on Section 11.2.
- 2) For line-to-line coupling mode, provide a 1kV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points, and for active line / neutral lines to ground are same except test level is 2kV.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are applied during test.
- 4) Different phase angles are done individually.
- 5) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

11.8. Test Results

EUT power supplies by DC Power, so this item test not applicable.

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11111

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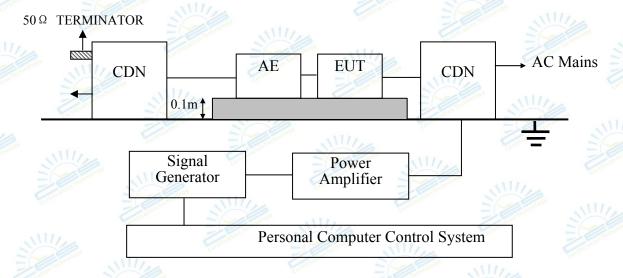


12. INJECTED CURRENTS SUSCEPTIBILITY TEST

12.1. Test Equipments

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.
	- Montaco		Cornina	=	dinan	Interval
1.	Conducted Immunity Test System	Frankonia	CIT-10/75	12681247/20 13	Jan 20, 14	1 Year
2.	Fixed Coaxial Attenuator	CD	ATT-0675	120540086	Jan 20, 14	1 Year
3.	coupling-decoup ling network (CDN)	CD	CDN M2/M3	2302	Jan 20, 14	1 Year
4.	Electromagnetic Injection Clamp (EMC-Clamp)	CD	EM-Clamp	0513A03120 1	Jan 20, 14	1 Year

12.2. Block Diagram of Test Setup



12.3. Test Standard

EN 55024: 2010 (IEC61000-4-6: 2008) (Severity Level 2 at 3V (r.m.s.) and frequency is from 0.15MHz to 80MHz)

12.4. Severity Levels and Performance Criterion

12.4.1. Severity level

Level Voltage Level (e.m.f.)		
1.=	311/.1	
2.	3	
3.	10	
X	Special	

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12.4.2. Performance criterion: A

12.5. EUT Configuration

The configurations of EUT are listed in Section 3.5.

12.6. Operating Condition of EUT

Same as Conducted Emission test that is listed in Section 3.6. except the test set up replaced by Section 12.2.

12.7. Test Procedure

- 1) Set up the EUT, CDN and test generators as shown on Section 12.2.
- 2) Let the EUT work in test mode and test it.
- The EUT are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 10 and 30 mm (where possible).
- 4) The disturbance signal described below is injected to EUT through CDN.
- 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- 6) The frequency range is swept from 0.150MHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave.
- 7) The rate of sweep shall not exceed 1.5*10⁻³decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 8) Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

12.8. Test Results

EUT power supplies by DC Power, so this item test not applicable.

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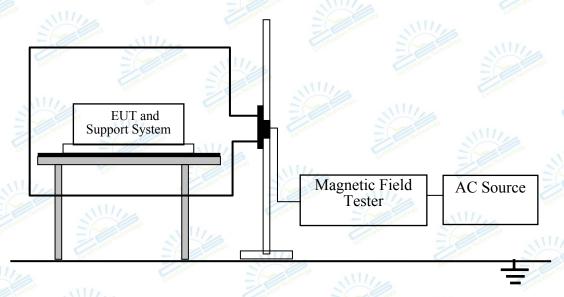


13. MAGNETIC FIELD IMMUNITY TEST

13.1. Test Equipments

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1 certifica	Magnetic Field Tester	HEAFELY	MAG100.1	083858-10	Jan 20, 14	1 Year

13.2. Block Diagram of Test Setup



13.3. Test Standard

EN 55024: 2010 (IEC 61000-4-8: 2009) (Severity Level 1 at 1A/m)

13.4. Severity Levels and Performance Criterion

13.4.1. Severity level

Level	Magnetic Field Strength A/m				
111111111111111111111111111111111111111	1				
2.	3				
3.	10				
11//4.	30				
5.	100				
X. 🦪	Special				

13.4.2. Performance criterion : A



13.5. EUT Configuration on Test

The configurations of EUT are listed in Section 3.5.

13.6. Operating Condition of EUT

Same as Conducted Emission test that is listed in Section 3.6. except the test set up replaced by Section 13.2.

13.7. Test Procedure

The EUT was subjected to the test magnetic field by using the induction coil of standard dimensions (1m*1m) and shown in Section 13.2. The induction coil was then rotated by 90° in order to expose the EUT to the test field with different orientations.

13.8. Test Results

The EUT not containing device susceptible to magnetic fields, and Power-frequency magnetic field test applicable only to EUT containing devices susceptible to magnetic fields, so the test not applicable.

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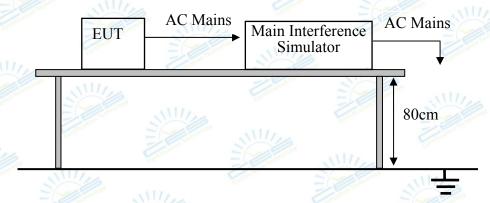


14. VOLTAGE DIPS AND INTERRUPTIONS TEST

14.1. Test Equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
	Main Interference	3ctest	VDG-1105G	EC0171002	Jan 20, 14	1 Year
	Simulator	and a sale	.117.	Car	aton rechi	11111

14.2. Block Diagram of Test Setup



14.3. Test Standard

EN 55024: 2010 (IEC 61000-4-11: 2004)

14.4. Severity Levels and Performance Criterion

14.4.1. Severity level

Test Level %U _T	Voltage dip and short interruptions %UT	Performance Criterion	Duration (in period)	
0	100	C	250	
0	100	В	0.5	
30	70	C	25	

14.4.2. Performance criterion: **B & C**

14.5. EUT Configuration

The configurations of EUT are listed in Section 3.5.

14.6. Operating Condition of EUT

Same as Conducted Emission test that is listed in Section 3.6. except the test set up replaced by Section 14.2.

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14.7. Test Procedure

- 1) The EUT and test generator were setup as shown on Section 14.2.
- 2) The interruption is introduced at selected phase angles with specified duration.
- 3) Record any degradation of performance.

14.8. Test Results

EUT power supplies by DC Power, so this item test not applicable.

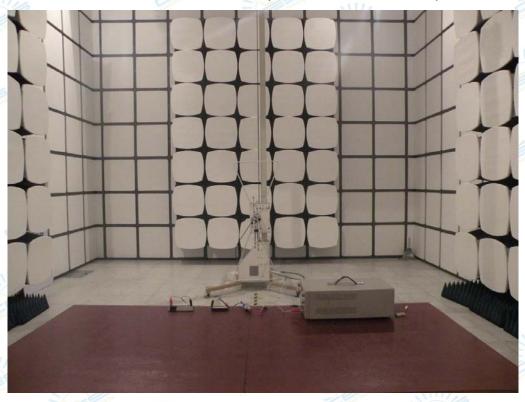
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15. PHOTOGRAPHS

15.1. Photos of Radiated Emission Test (In Anechoic Chamber)



15.2. Photos of Electrostatic Discharge Immunity Test



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16. PHOTOS OF THE EUT



Front View

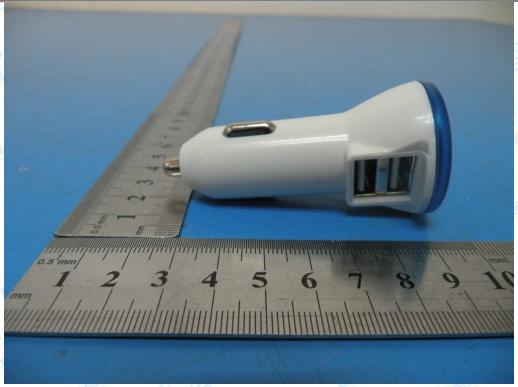


Rear View

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Left View



Right View

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Top View

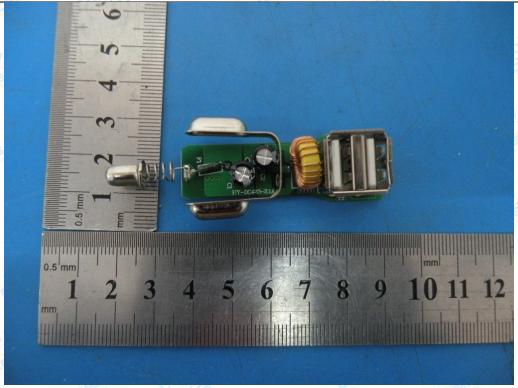


Bottom View

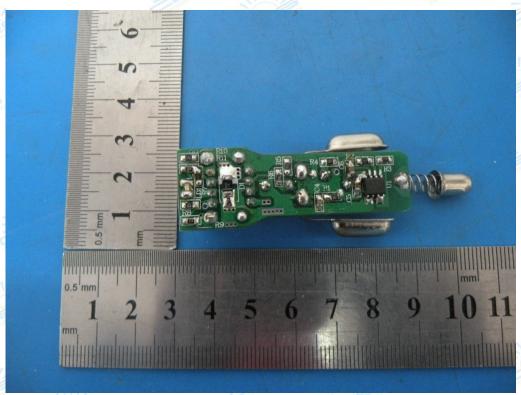
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Inside View



Inside View -----THE END OF REPORT------

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